

## OptiMOS™ - 6 Power-Transistor



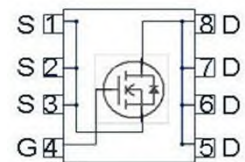
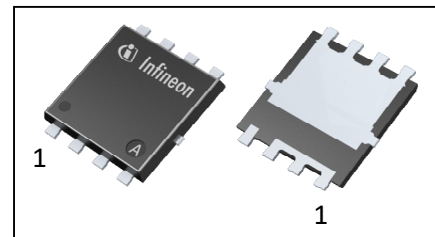
### Features

- OptiMOS™ - power MOSFET for automotive applications
- N-channel - Enhancement mode - Logic Level
- AEC Q101 qualified
- MSL1 up to 260°C peak reflow
- 175°C operating temperature
- Green Product (RoHS compliant)
- 100% Avalanche tested

### Product Summary

$V_{DS}$	40	V
$R_{DS(on),max}$	0.55	mΩ
$I_D$	120	A

PG-TDSON-8-53



Type	Package	Marking
IAUC120N04S6L005	PG-TDSON-8-53	6N04L005

**Maximum ratings**, at  $T_j=25\text{ °C}$ , unless otherwise specified

Parameter	Symbol	Conditions	Value	Unit
Drain current	$I_D$	$V_{GS}=10V$ , Chip Limitation <sup>1,2)</sup>	435	A
		$V_{GS}=10V$ , DC current <sup>3)</sup>	120	
		$T_a=85\text{ °C}$ , $V_{GS}=10V$ , $R_{thJA}$ on 2s2p <sup>4,5)</sup>	60	
Pulsed drain current <sup>5)</sup>	$I_{D,pulse}$	$T_C=25\text{ °C}$ , $t_p=100\mu s$	1550	
Avalanche energy, single pulse <sup>2)</sup>	$E_{AS}$	$I_D=60A$ , $R_G=25\Omega$	750	mJ
Avalanche current, single pulse	$I_{AS}$	$R_G=25\Omega$	120	A
Gate source voltage	$V_{GS}$	-	±16	V
Power dissipation	$P_{tot}$	$T_C=25\text{ °C}$	187	W
Operating and storage temperature	$T_j$ , $T_{stg}$	-	-55 ... +175	°C

Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	

#### Thermal characteristics

Thermal resistance, junction - case <sup>5)</sup>	$R_{thJC}$	-	-	-	0.8	K/W
Thermal resistance, junction - ambient <sup>4)</sup>	$R_{thJA}$	-	-	26	-	

#### Electrical characteristics, at $T_j=25^\circ\text{C}$ , unless otherwise specified

#### Static characteristics

Drain-source breakdown voltage	$V_{(BR)DSS}$	$V_{GS}=0V, I_D=1mA$	40	-	-	V
Gate threshold voltage	$V_{GS(th)}$	$V_{DS}=V_{GS}, I_D=130\mu A$	1.2	1.6	2.0	
Zero gate voltage drain current	$I_{DSS}$	$V_{DS}=40V, V_{GS}=0V, T_j=25^\circ\text{C}$	-	-	1	$\mu A$
		$V_{DS}=40V, V_{GS}=0V, T_j=125^\circ\text{C}^{2)}$	-	-	33	
Gate-source leakage current	$I_{GSS}$	$V_{GS}=16V, V_{DS}=0V$	-	-	100	nA
Drain-source on-state resistance	$R_{DS(on)}$	$V_{GS}=4.5V, I_D=60A$	-	0.57	0.80	m $\Omega$
		$V_{GS}=10V, I_D=60A$	-	0.43	0.55	

Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	

### Dynamic characteristics<sup>2)</sup>

Input capacitance	$C_{iss}$	$V_{GS}=0V, V_{DS}=25V,$ $f=1MHz$	-	8423	11203	pF
Output capacitance	$C_{oss}$		-	2294	2982	
Reverse transfer capacitance	$C_{rss}$		-	117	175	
Turn-on delay time	$t_{d(on)}$	$V_{DD}=20V, V_{GS}=10V,$ $I_D=120A, R_G=3.5\Omega$	-	9	-	ns
Rise time	$t_r$		-	8	-	
Turn-off delay time	$t_{d(off)}$		-	57	-	
Fall time	$t_f$		-	28	-	

### Gate Charge Characteristics<sup>2)</sup>

Gate to source charge	$Q_{gs}$	$V_{DD}=32V, I_D=120A,$ $V_{GS}=0 \text{ to } 10V$	-	23	30	nC
Gate to drain charge	$Q_{gd}$		-	25	38	
Gate charge total	$Q_g$		-	136	177	
Gate plateau voltage	$V_{plateau}$		-	2.8	-	V

### Reverse Diode

Diode continuous forward current <sup>5)</sup>	$I_S$	$T_C=25^\circ C$	-	-	120	A
Diode pulse current <sup>5)</sup>	$I_{S,pulse}$		-	-	1550	
Diode forward voltage	$V_{SD}$	$V_{GS}=0V, I_F=60A,$ $T_j=25^\circ C$	-	0.8	1.1	V
Reverse recovery time <sup>2)</sup>	$t_{rr}$	$V_R=20V, I_F=50A,$ $di_F/dt=100A/\mu s$	-	71	-	ns
Reverse recovery charge <sup>2)</sup>	$Q_{rr}$		-	98	-	nC

<sup>1)</sup> Practically the current is limited by overall system design including customer specific PCB.

<sup>2)</sup> The parameter is not subject to production test - verified by characterization.

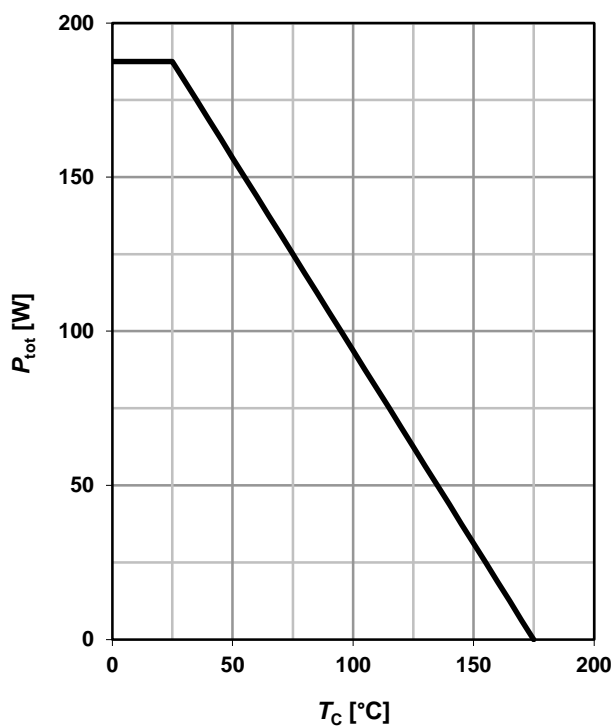
<sup>3)</sup> The product can operate at specified current based on best practice to minimize electromigration at the solder joint. For rare events and inrush currents the value may be exceeded.

<sup>4)</sup> Device on 2s2p FR4 PCB defined in accordance with JEDEC standards (JESD51-5, -7). PCB is vertical in still air.

<sup>5)</sup> The parameter is not subject to production test - verified by design.

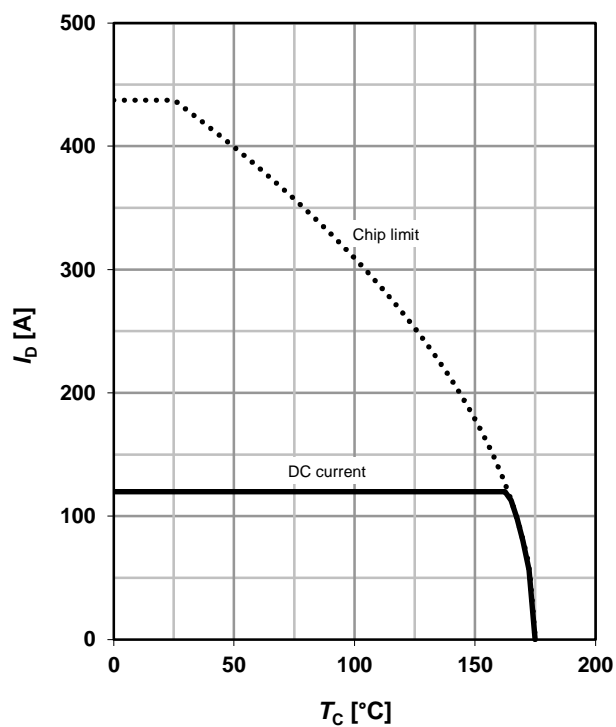
### 1 Power dissipation

$$P_{\text{tot}} = f(T_C); V_{\text{GS}} = 10 \text{ V}$$



### 2 Drain current

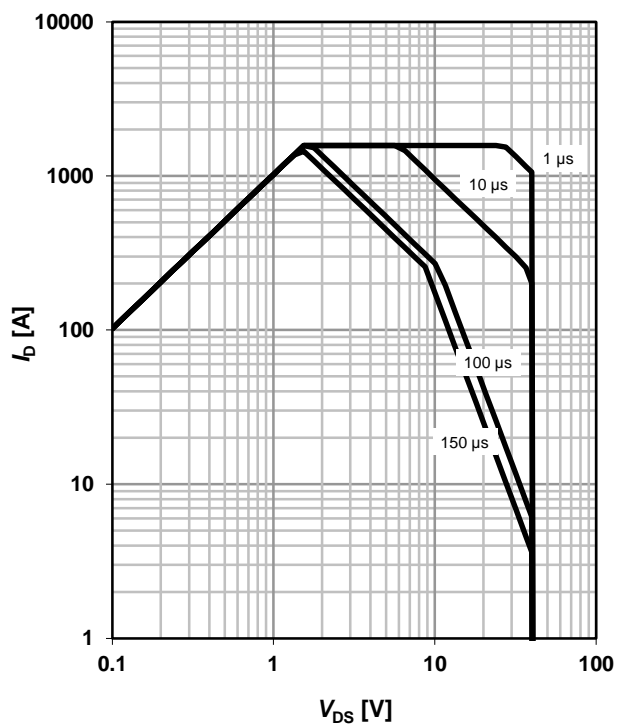
$$I_D = f(T_C); V_{\text{GS}} = 10 \text{ V}$$



### 3 Safe operating area

$$I_D = f(V_{\text{DS}}); T_C = 25 \text{ °C}; D = 0$$

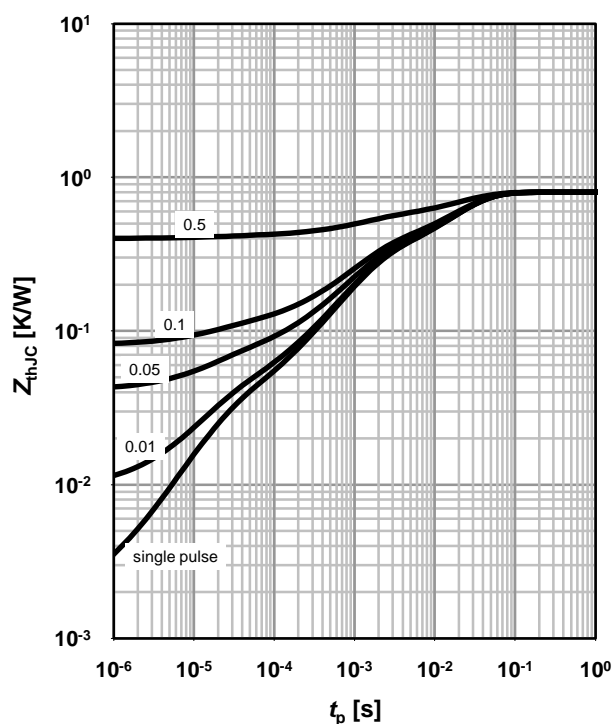
parameter:  $t_p$



### 4 Max. transient thermal impedance

$$Z_{\text{thJC}} = f(t_p)$$

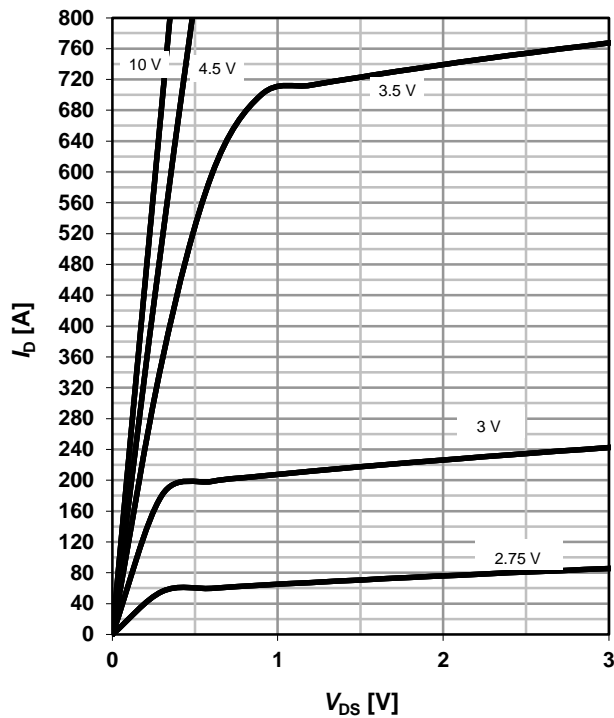
parameter:  $D = t_p/T$



## 5 Typ. output characteristics

$$I_D = f(V_{DS}); T_j = 25^\circ\text{C}$$

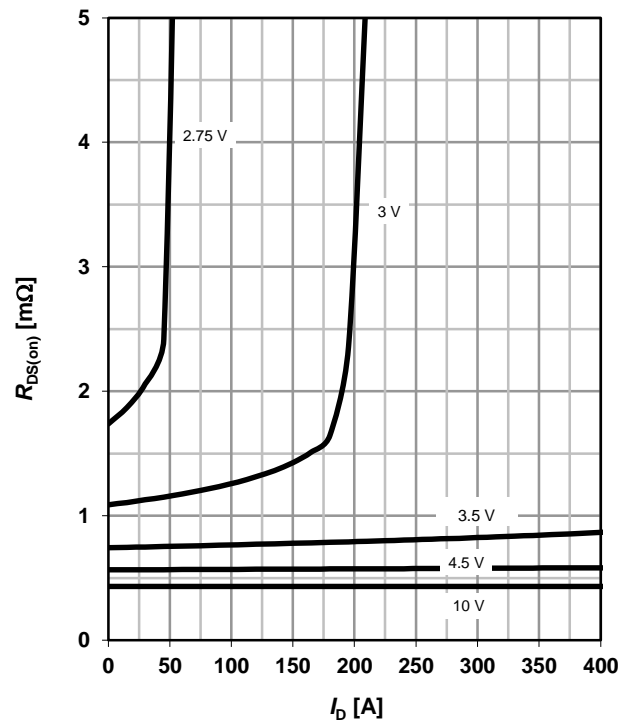
parameter:  $V_{GS}$



## 6 Typ. drain-source on-state resistance

$$R_{DS(on)} = f(I_D); T_j = 25^\circ\text{C}$$

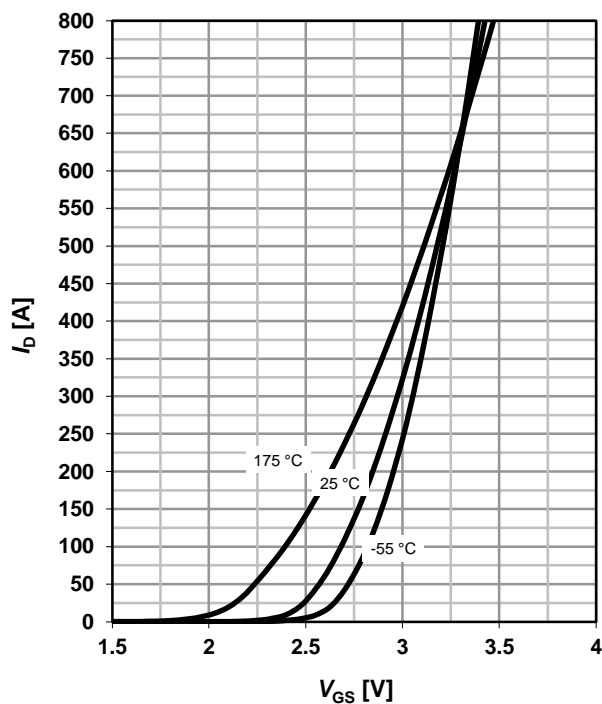
parameter:  $V_{GS}$



## 7 Typ. transfer characteristics

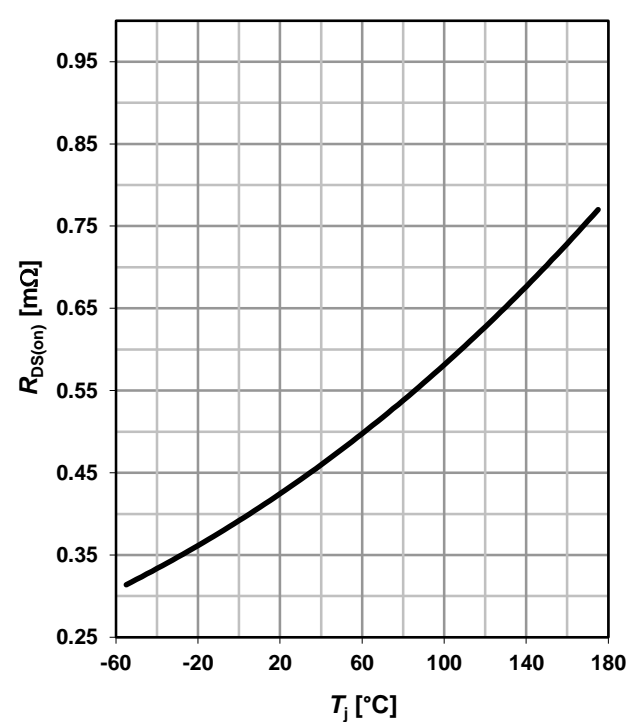
$$I_D = f(V_{GS}); V_{DS} = 6\text{V}$$

parameter:  $T_j$



## 8 Typ. drain-source on-state resistance

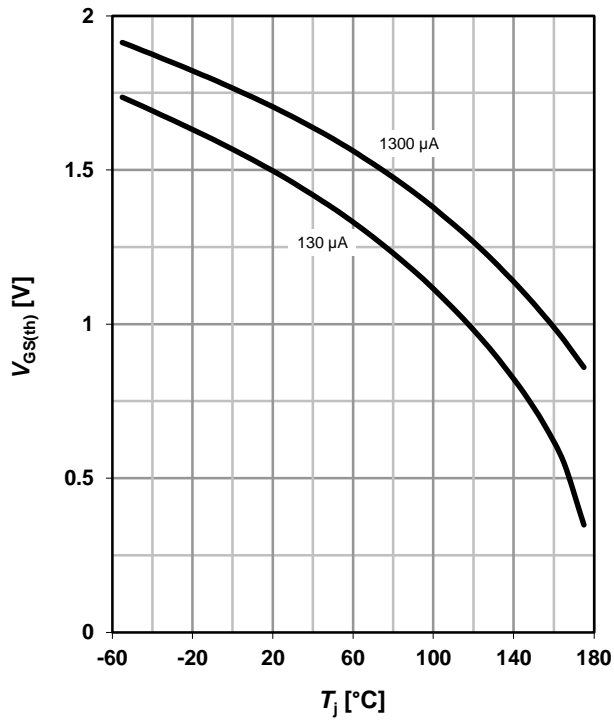
$$R_{DS(on)} = f(T_j); I_D = 60\text{ A}; V_{GS} = 10\text{ V}$$



## 9 Typ. gate threshold voltage

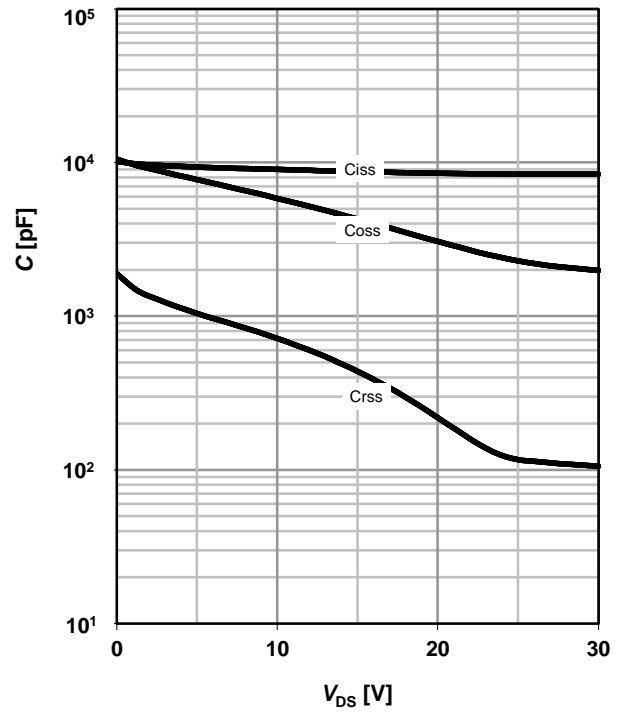
$$V_{GS(th)} = f(T_j); V_{GS} = V_{DS}$$

parameter:  $I_D$



## 10 Typ. capacitances

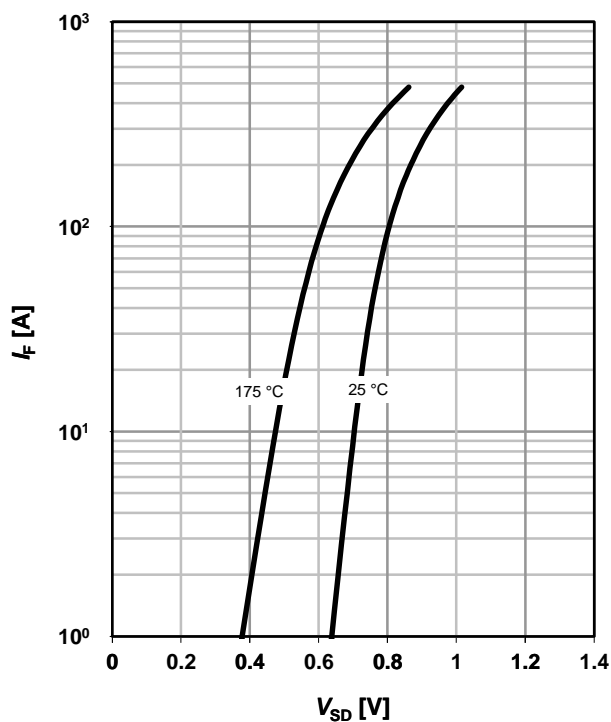
$$C = f(V_{DS}); V_{GS} = 0 \text{ V}; f = 1 \text{ MHz}$$



## 11 Typical forward diode characteristics

$$I_F = f(V_{SD})$$

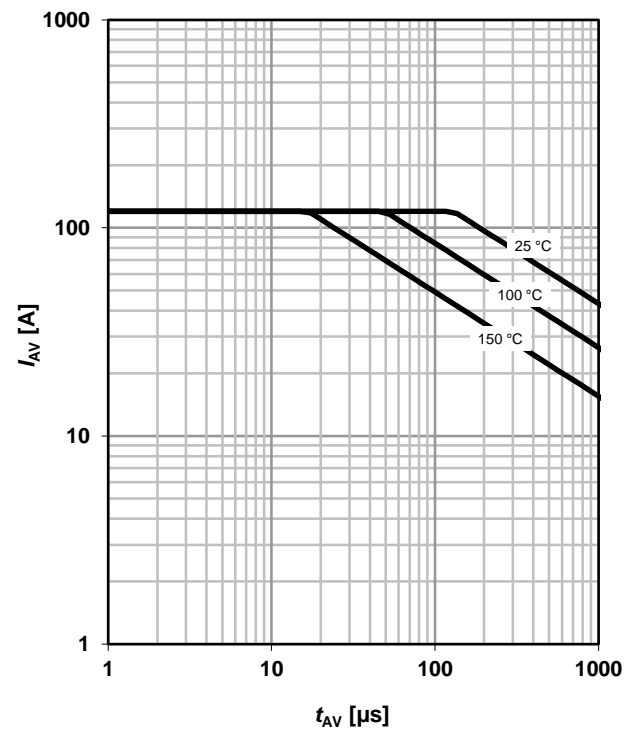
parameter:  $T_j$



## 12 Avalanche characteristics

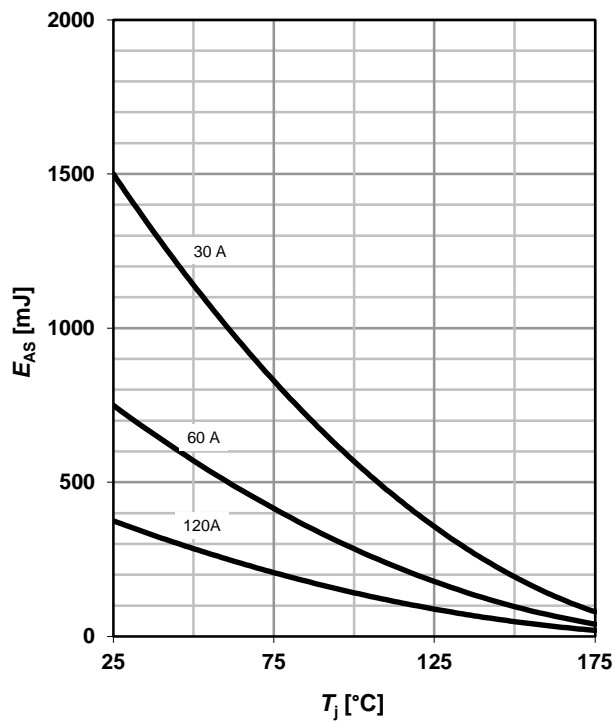
$$I_{AS} = f(t_{AV})$$

parameter:  $T_{j(start)} > 25^\circ C$



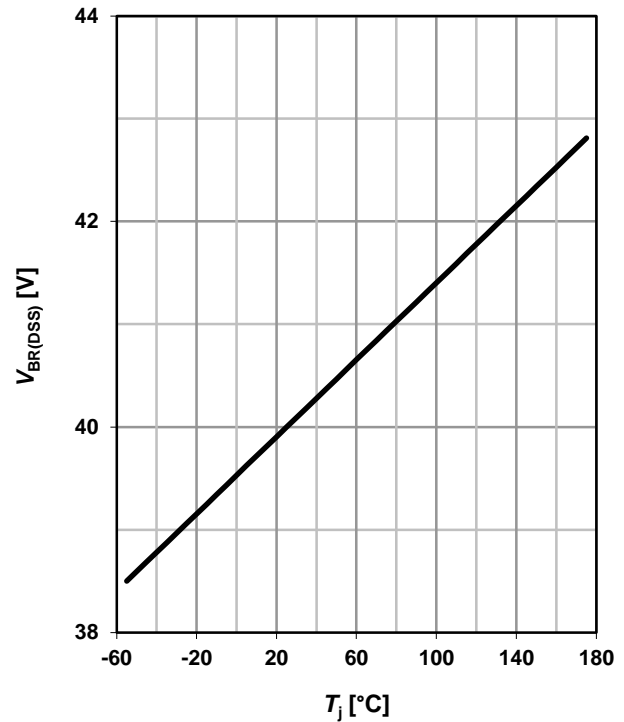
### 13 Avalanche energy

$$E_{AS} = f(T_j)$$



### 14 Drain-source breakdown voltage

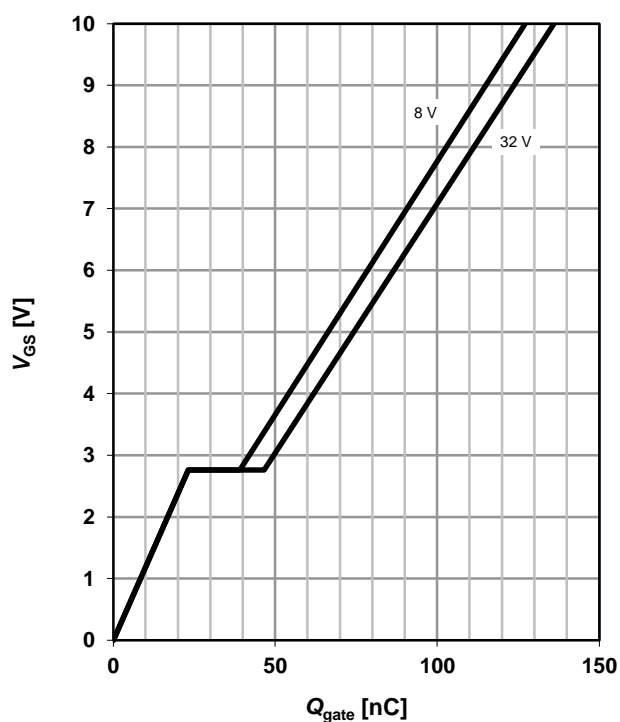
$$V_{BR(DSS)} = f(T_j); I_D = 1 \text{ mA}$$



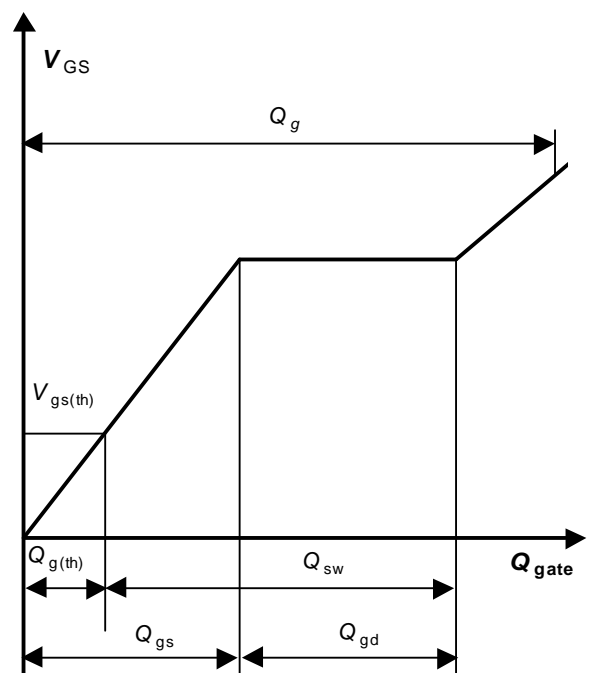
### 15 Typ. gate charge

$$V_{GS} = f(Q_{gate}); I_D = 120 \text{ A pulsed}$$

parameter:  $V_{DD}$



### 16 Gate charge waveforms



[illegible]

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- Technical drawing of the 1000 Series PCB. The top view shows a rectangular board with a width of 12 and a length of 6.9. There are six circular mounting holes along the top edge, with a center-to-center distance of 8 between the first two and 4 between the next two. A label 'PIN 1 INDEX MARKING' points to a specific location on the left side. The side view shows a thickness of 0.3 and a mounting feature with a width of 1.3.



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If they fail, it is reasonable to assume that the health of the user or other persons may be endangered.

## Revision History

Version	Date	Changes
Revision 1.0	05.06.2020	Final Data Sheet
Revision 1.1	05.02.2025	I <sub>S</sub> and I <sub>S,pulse</sub> update